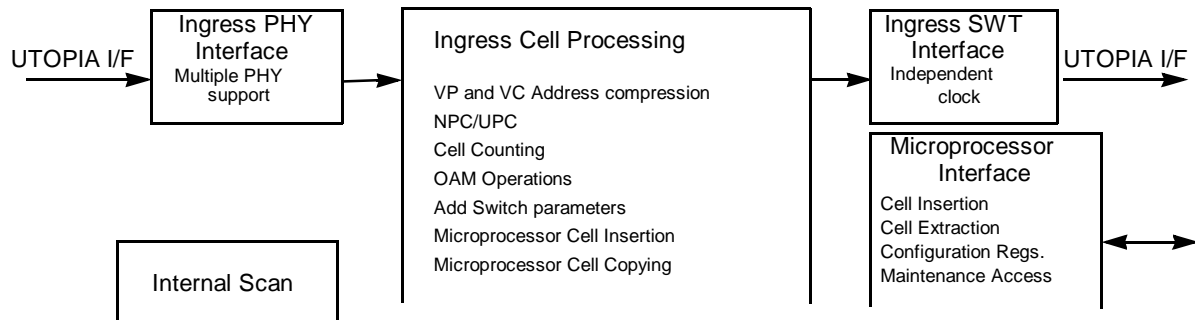


# MC92501

## Advance Information ATM Cell Processor

The MC92501 is an Asynchronous Transfer Mode (ATM) Cell Processor layer device composed of dedicated high-performance ingress and egress cell processors combined with UTOPIA Level 2-compliant physical (PHY) and UTOPIA Level 1-compliant switch interface (see **Figure 1**). It integrates address translation, UPC/NPC, OAM, and statistical functions into a single semiconductor device. This second generation ATM cell processor in Motorola's MC92500 series can be used both in the line cards used by the switching systems in the ATM network core and in the access multiplexer. The primary function of the MC92501 in either application is to provide ATM-layer cell processing and routing functions. The advanced ATM functionality permits simultaneous transmission of voice, video, and data within broadband services such as high-speed Internet operations, LAN interconnections for commuters, and video-on-demand using a variety of applications such as Digital Subscriber Line Access Multiplexers (DSLAMs), Wide-Area Networks (WANs), Enterprise Switches, and Multi-service Platforms,



This document contains information on a new product. Specifications and information herein are subject to change without notice.

Preliminary Data

**For More Information On This Product,  
Go to: [www.freescale.com](http://www.freescale.com)**

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**Telephone:** 1-800-521-6274

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**Internet:** <http://www.mot.com/SPS/MCTG/MDAD/atmc>

## Data Sheet Conventions

This data sheet uses the following conventions:

OVERBAR Used to indicate a signal that is active when pulled low (For example, the RESET pin is active when low.)

asserted Means that a high true (active high) signal is high or that a low true (active low) signal is low

deasserted Means that a high true (active high) signal is low or that a low true (active low) signal is high

Examples:	Signal/Symbol	Logic State	Signal State	Voltage
	$\overline{\text{PIN}}$	True	Asserted	$V_{IL}/V_{OL}$
	$\overline{\text{PIN}}$	False	Deasserted	$V_{IH}/V_{OH}$
	PIN	True	Asserted	$V_{IH}/V_{OH}$

## New Features in the MC92501

- Implements ATM Layer functions for Broadband ISDN according to ANSI recommendations, ATM Forum UNI 4.0 and TM 4.0 Specifications, ITU recommendations, and Bellcore recommendations.
- Provides ABR Relative Rate marking and EFCI marking according to TM 4.0
- Select Discard CLP = 1 (or CLP = 0 + 1) Flow on selected connections
- UTOPIA Level 2 PHY Interface and UTOPIA ATM Layer Interface
- Supports both Partial Packet Discard (PPD) and Early Packet Discard (EPD)
- Change ABR RM Cell priority
- Supports CLP transparency
- Unidirectional (Ingress or Egress) UPC or NPC

## Standard ATMC Features in the MC92500 Family

- Full duplex operation at data rates up to 155 Mbps
- Performs internal VPI and VCI address compression for up to 64 K VCs
- CLP-Aware peak, average, and burst-length policing with programmable Tag/Drop action per policer
- Supports up to 16 physical links using dedicated Ingress/Egress multiPHY control signals
- Each physical link can be configured as either a UNI or NNI port
- Supports multicast, multiport address translation
- Maintains both virtual connection and physical link counters on both Ingress and Egress cell flows
- Provides a flexible 32-bit external memory port for context management

## Product Documentation

The three documents listed in the following table are required for complete description of the MC92501 and are necessary to design properly with the part. Documentation is available from one of the following locations (see back cover for detailed information):

- A local Motorola distributor
- A Motorola semiconductor sales office
- A Motorola Literature Distribution Center
- The World Wide Web (WWW)

**Table 1.** MC92501 Documentation

Name	Description	Order Number
MC92501 Product Brief	MC92501 product overview	MC92501/P
MC92501 Technical Data	MC92501 features list and physical, electrical, timing, and package specifications	MC92501/D
MC92501 User's Manual	Detailed functional description of the MC92501 configuration, operation, and register programming	MC92501UM/D
ATM Cell Processor Evaluation Board User's Manual	Detailed description of the ATMC EVB hardware, operation, installation, and design recommendations	MC92501EVKUM/D



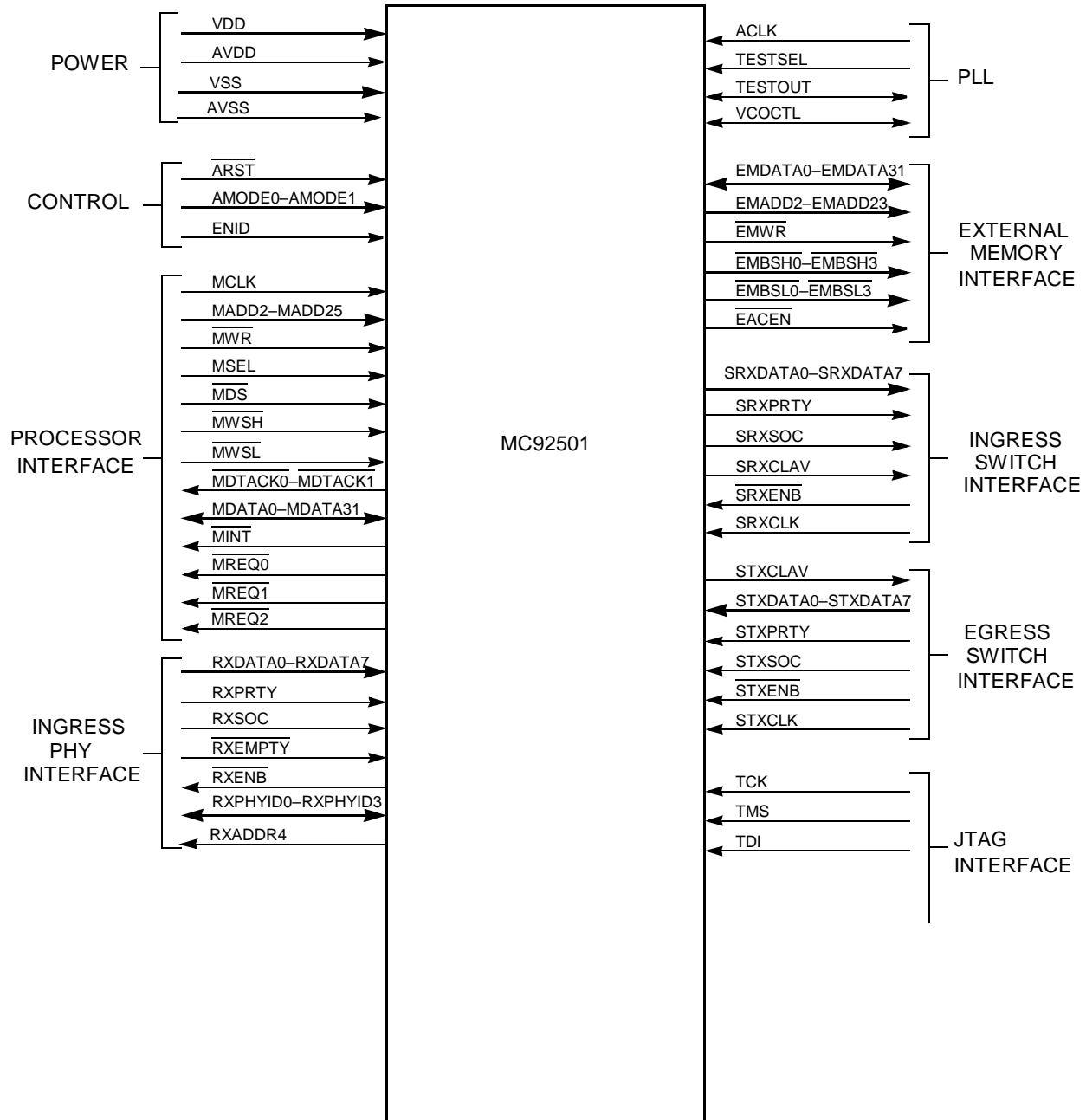
# Signal Descriptions

## 1.1 Signal Groupings

The input and output signals of the MC92501 are organized into functional groups, as shown in **Table 1-1** and as illustrated in **Figure 1-1**. The MC92501 is operated from a 3.3 V supply; however, some of the inputs can tolerate 5 V. A special note for this feature is added to the signal descriptions of those inputs.

**Table 1-1.** MC92501 Functional Signal Groupings

Functional Group	Number of Signals	Detailed Description
Power (VDD and AVDD) and Ground (VSS and AVSS)	47	<b>Table 1-2</b>
Control	4	<b>Table 1-3</b>
Processor Interface	68	<b>Table 1-4</b>
Ingress PHY Interface	17	<b>Table 1-6</b>
Egress PHY Interface	18	<b>Table 1-7</b>
PLL	4	<b>Table 1-8</b>





## 1.2 Power and Ground Signals

**Table 1-2.** Power and Ground Signals

Signal Name	Description
VDD	<b>Input Power</b>
AVDD	<b>PLL Analog Power</b> —Isolate this input to eliminate coupling of digital switching noise into the PLL
VSS	<b>System Ground</b>
AVSS	<b>PLL Analog Ground</b> —Isolate this input to eliminate coupling of digital switching noise into the PLL

## 1.3 Control Signals

**Table 1-3.** Control Signals

Signal Name	Signal Type	Detailed Description
$\overline{\text{ARST}}$	Input	<b>ATMC Power-up Reset</b> —This input signal is used for power-up reset of the entire chip. It must be asserted for at least the time required by the PLL to stabilize.
AMODE0– AMODE1	Input	<b>ATMC Mode</b> —These input signals determine the operating mode of the chip's test features. In normal usage these pins should be grounded.

## 1.4 Processor Interface Signals

**Table 1-4.** Processor Interface Signals

Signal Name	Signal Type	Detailed Description
MCLK	Input	<b>MP Clock</b> —This input signal is used as the Microprocessor clock inside the MC92501. This signal drives the microprocessor logic in the MC92501. The duty cycle should be in the range of 40–60%.
MADD2– MADD25	Input	<b>MP Address Bus</b> —This input bus contains the address which is used by the microprocessor to define the register being accessed. This bus is used by the MC92501 at the assertion of MSEL and sampled on the falling edge of MCLK.
MWR	Input	<b>MP Write</b> —This input signal is used to determine whether the MP is reading from the MC92501 or writing to it. This signal is sampled by the MC92501 on the falling edge of MCLK. The MC92501 drives MDATA when MSEL = 0 and MWR = 1.
MSEL	Input	<b>MP Select</b> —This input signal is used to determine that the current access to the MC92501 is valid. This signal is sampled by the MC92501 on the falling edge of MCLK.
MDS	Input	<b>MP Data Select</b> —This input signal is used to indicate when the data on MDATA is valid during a write access to the MC92501. This signal is sampled by the MC92501 on the falling edge of MCLK.
MWSH  A1	Input  Input	<b>MP Word Write Enable High</b> —This signal indicates that the high word is being written. During a maintenance write access, the value detected on MWSH/A1 is driven on the appropriate EMBSH signal. During read access EMBSH signal is always asserted. <b>Address 1</b> —When configured appropriately during a maintenance write access, this signal serves as Address 1. During a read access, this

**Table 1-4. Processor Interface Signals (Continued)**

Signal Name	Signal Type	Detailed Description
MDTACK0–MDTACK1	Output	<b>MP Data Acknowledge 0–1</b> —These tri-statable output signals are used to indicate the end of an access from the MC92501. At the end of each access, this signal is actively pulled up and then released. The user may program the MC92501 not to drive this signal during certain types of accesses. This signal is output asynchronously to MCLK.
MDATA0–MDATA31	Input/Output	<b>MP Data Bus</b> —This tri-state bidirectional bus provides the general data path between the MC92501 and the microprocessor.
MINT	Output	<b>MP Interrupt</b> —This output signal is used to notify the microprocessor of the occurrence of interrupting events. This signal is asserted on the rising edge of ACLK (asynchronous with respect to MCLK).
$\overline{\text{MREQ0}}$	Output	<b>MP Request 0</b> —This output signal can be programmed to one of three options (described below in note 2). Its default value is option #1: MP Cell In Request (MCIREQ).
$\overline{\text{MREQ1}}$	Output	<b>MP Request 1</b> —This output signal can be programmed to one of three options (described below in note 2). Its default value is option #2: MP Cell Out Request (MCOREQ)..
$\overline{\text{MREQ2}}$	Output	<b>MP Request 2</b> —This output signal can be programmed to one of three options (described below in note 2). Its default value is option #3: External Memory Maintenance Request (EMMREQ).

- Notes:**
- All inputs are 5 V tolerant.
  - $\overline{\text{MREQ0}}$ ,  $\overline{\text{MREQ1}}$  and  $\overline{\text{MREQ2}}$  signals are fully backward compatible to the MC92501 Revision A MCIREQ, MCOREQ and EMMREQ signals, respectively. The  $\overline{\text{MREQ[n]}}$  signals are used by DMA devices and can be programmed to support DMA requests as follows:
    - *MP Cell In Request:*  $\overline{\text{MREQ[n]}}$  is an output signal that can be used by an external DMA device as a control line indicating when to start a new cell insertion cycle into the

**Table 1-5. Host Interface Fields**

<i>WSSM</i> = 0		<i>WSSM</i> = 1 and DO-Data Order = 0		<i>WSSM</i> = 1 and DO-Data Order=1		Function
$\overline{\text{MWSH}}$	$\overline{\text{MWSL}}$	A1	Size	A1	Size	
0	0	x	0	x	0	Write D(31:0)
0	1	0	1	1	1	Write D(31:16)
1	0	1	1	0	1	Write D(15:00)

**Note:** All Cell Extraction Register, Cell Insertion Register, and General Register accesses are long-word (32-bit) accesses, so both  $\overline{\text{MWSH}}$ /A1 and  $\overline{\text{MWSL}}$ /SIZE should be asserted low for these write accesses when write-enable mode is selected.

## 1.5 Ingress PHY Interface Signals

**Table 1-6. Ingress PHY Interface Signals**

Signal Name	Signal Type	Detailed Description
RXDATA0–RXDATA7	Input	<b>Receive Data Bus</b> —This input data bus receives octets from the PHY chip. When $\text{RXENB}$ is active, RXDATA is sampled into the MC92501.
RXPRTY	Input	<b>Receive Data Bus Parity (RXPRTY)</b> —This input is the odd parity over RXDATA. This input is ignored if $\text{RXENB}$ is not active or the parity check is disabled.

All inputs are 5 V tolerant.

## 1.6 Egress PHY Interface Signals

**Table 1-7.** Egress PHY Interface Signals

Signal Name	Signal Type	Detailed Description
$\overline{\text{TXFULL}}$	Input	<b>Transmit PHY Full</b> —This input signal indicates, when low, that the PHY device is full.
TXDATA0– TXDATA7	Output	<b>Transmit Data Bus</b> —This output data bus transmits octets to the PHY chip. When $\overline{\text{TXENB}}$ is active, TXDATA contains a valid octet for the PHY.
TXPRTY	Output	<b>Transmit Data Bus Parity</b> —This output signal is the odd parity over TXDATA. When $\overline{\text{TXENB}}$ is active, TXPRTY is a valid parity bit for the PHY.
TXSOC	Output	<b>Transmit Start Of Cell</b> —This output signal indicates, when high, that the current data on TXDATA is the first byte of a cell. TXSOC is valid when $\overline{\text{TXENB}}$ is asserted.
$\overline{\text{TXENB}}$	Output	<b>Transmit Enable</b> —This output signal, when low, indicates that TXDATA, TXPRTY, and TXSOC are valid data for the PHY.
$\overline{\text{TXCCLR}}$	Input	<b>Transmit Cell Clear</b> —This input signal indicates, when low, that the current cell should be cleared from the Egress PHY interface.
TXPHYID0– TXPHYID3	Output	<b>Transmit PHY ID 0–3</b> —In UTOPIA level 1, this is an output bus that indicates the ID number of the PHY device to which either the current cell or the next cell is directed. The functionality is controlled by the MC92501 General Configuration Register (GCR). <b>Transmit Address 0–3</b> —In UTOPIA level 2, this is an output bus that indicates the 4 least significant bits of the ID number of the PHY device which is being polled or selected by the MC92501.
TXADDR0– TXADDR3	Output	

## 1.7 PLL Signals

**Table 1-8. PLL Signals**

Signal Name	Signal Type	Detailed Description
ACLK	Input	<b>ATMC Master Clock</b> —This input signal is used by the PLL to generate the internal master clock of MC92501. The duty cycle should be in the range of 40–60%.
TESTSEL	Input	This is a dedicated test signal that must be grounded during normal system operation.
TESTOUT	Input/Output	This is a dedicated test signal that must be connected to the analog ground (AVSS) during normal system operation.
VCOCTL	Input/Output	This is a dedicated test signal that must be connected to the analog ground (AVSS) during normal system operation.

**Note:** All inputs are 5 V tolerant.

## 1.8 External Memory Interface Signals

**Table 1-9. External Memory Interface Signals**

Signal Name	Signal Type	Detailed Description
EMDATA0–	Input/Output	<b>External Memory Data Bus</b> —This tri-statable bidirectional bus is the

**Table 1-9.** External Memory Interface Signals (Continued)

Signal Name	Signal Type	Detailed Description
EACEN	Output	<b>External Address Compression Enable</b> —This output signal is asserted when data is being written to or read from an external address compression device using the External Memory Data Bus.

**Note:** All inputs are 5 V tolerant.

## 1.9 Ingress Switch Interface Signals

**Table 1-10.** Ingress Switch Interface Signals

Signal Name	Signal Type	Detailed Description
SRXDATA0–SRXDATA7	Output	<b>Receive DATA BUS (SRXDATA0–SRXDATA7)</b> —This three-state output data bus transmits bytes to the switch. When SRXENB is active, SRXDATA contains valid data for the switch. This bus is updated on the rising edge of SRXCLK.
SRXPRTY	Output	<b>Receive Data Bus Parity</b> —This three-state output is the parity protection of SRXDATA transmitted to the switch. The type of parity (even/odd) is defined by the Ingress Switch Interface Configuration Register (ISWCR)..
SRXSOC	Output	<b>Receive Start Of Cell</b> —This three-state output, when high, indicates that the current data on SRXDATA is the first byte of a cell structure (including the overhead bytes).

## 1.10 Egress Switch Interface Signals

**Table 1-11. Egress Switch Interface Signals**

Signal Name	Signal Type	Detailed Description
STXCLAV	Output	<b>Transmit Cell Available</b> —This output, when asserted, indicates that the MC92501 is prepared to receive a complete cell.
STXDATA0–STXDATA7	Input	<b>Transmit Data Bus</b> —This input data bus receives bytes from the switch. When STXENB is asserted, STXDATA is sampled into the MC92501 on the rising edge of STXCLK.
STXPRTY	Input	<b>Transmit Data Bus Parity</b> —This input is the parity over STXDATA. The type of parity (even/odd) and the parity check control are defined by the Egress Switch Interface Configuration Register (ESWCR). This input is ignored if STXENB is deasserted or the parity check is disabled. It is sampled on the rising edge of STXCLK.
STXSOC	Input	<b>Transmit Start Of Cell</b> —This input indicates, when high, that the current data is the first byte of a cell structure (including the overhead bytes). This input is sampled on the rising edge of STXCLK when STXENB is asserted.
STXENB	Input	<b>Transmit Enable</b> —This input, when low, enables STXDATA, STXPRTY, and STXSOC.
STXCLK	Input	<b>Transmit Clock</b> —This input signal is used to clock the Egress switch interface signals.

**Note:** All inputs are 5 V tolerant.

## 1.11 JTAG Interface Signals



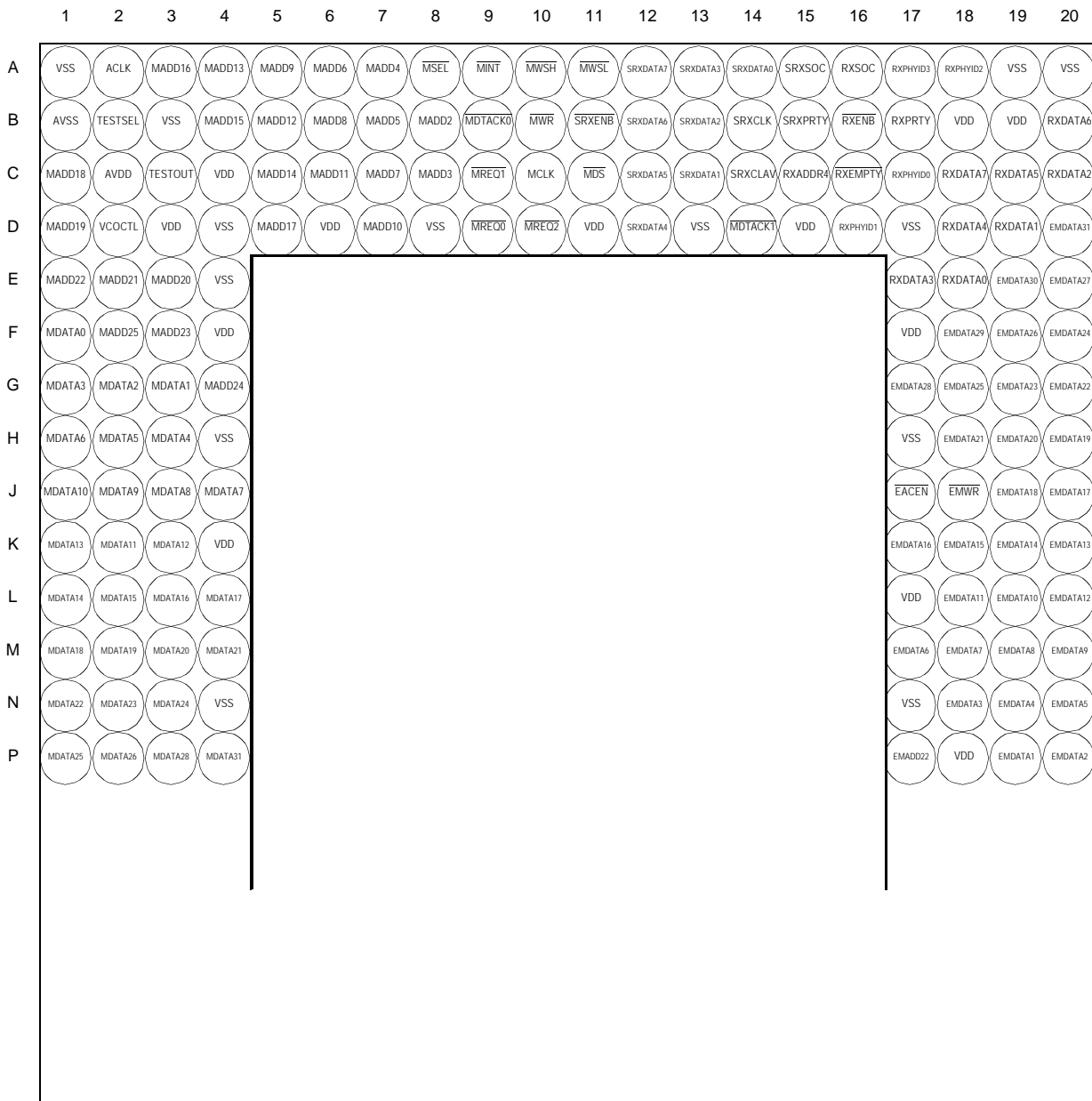
## Signal and Packaging Information

### 2.1 Introduction

This section provides information on packaging, including a diagram of the package with signals and tables showing how the signals described in **Section 1** are allocated. The MC92501 is available in a 256-lead Glob-Top Ball Grid Array (GTBGA) package. The package mechanical drawing is provided at the end of this section.

## 2.2 GTBGA Package Description

A GTBGA package top view is shown in **Figure 2-1** with signal and location designators.



**Table 2-1. MC92501 256-Lead GTBGA Package Signal List by Location**

Location	Signal Name	Location	Signal Name	Location	Signal Name	Location	Signal Name
A1	VSS	B1	AVSS	C1	MADD18	D1	MADD19
A2	ACLK	B2	TESTSEL	C2	AVDD	D2	VCCTL
A3	MADD16	B3	VSS	C3	TESTOUT	D3	VDD
A4	MADD13	B4	MADD15	C4	VDD	D4	VSS
A5	MADD9	B5	MADD12	C5	MADD14	D5	MADD17
A6	MADD6	B6	MADD8	C6	MADD11	D6	VDD
A7	MADD4	B7	MADD5	C7	MADD7	D7	MADD10
A8	$\overline{\text{MSEL}}$	B8	MADD2	C8	MADD3	D8	VSS
A9	$\overline{\text{MINT}}$	B9	$\overline{\text{MDTACK0}}$	C9	$\overline{\text{MREQ1}}$	D9	$\overline{\text{MREQ0}}$
A10	$\overline{\text{MWSH/A1}}$	B10	$\overline{\text{MWR}}$	C10	MCLK	D10	$\overline{\text{MREQ2}}$
A11	$\overline{\text{MWSL/SIZE}}$	B11	$\overline{\text{SRXENB}}$	C11	$\overline{\text{MDS}}$	D11	VDD
A12	SRXDATA7	B12	SRXDATA6	C12	SRXDATA5	D12	SRXDATA4
A13	SRXDATA3	B13	SRXDATA2	C13	SRXDATA1	D13	VSS
A14	SRXDATA0	B14	SRXCLK	C14	SRXCLAV	D14	$\overline{\text{MDTACK1}}$
A15	SRXSOC	B15	SRXPRTY	C15	RXADDR4	D15	VDD
A16	RXSOC	B16	$\overline{\text{RXENB}}$	C16	$\overline{\text{RXEMPTY}}$	D16	RXPHYID1/ RXADDR1

**Table 2-1. MC92501 256-Lead GTBGA Package Signal List by Location (Continued)**

Location	Signal Name	Location	Signal Name	Location	Signal Name	Location	Signal Name
E1	MADD22	H1	MDATA6	L1	MDATA14	P1	MDATA25
E2	MADD21	H2	MDATA5	L2	MDATA15	P2	MDATA26
E3	MADD20	H3	MDATA4	L3	MDATA16	P3	MDATA28
E4	VSS	H4	VSS	L4	MDATA17	P4	MDATA31
E17	RXDATA3	H17	VSS	L17	VDD	P17	EMADD22
E18	RXDATA0	H18	EMDATA21	L18	EMDATA11	P18	VDD
E19	EMDATA30	H19	EMDATA20	L19	EMDATA10	P19	EMDATA1
E20	EMDATA27	H20	EMDATA19	L20	EMDATA12	P20	EMDATA2
F1	MDATA0	J1	MDATA10	M1	MDATA18	R1	MDATA27
F2	MADD25	J2	MDATA9	M2	MDATA19	R2	MDATA29
F3	MADD23	J3	MDATA8	M3	MDATA20	R3	TXPHYID0/ TXADDR0
F4	VDD	J4	MDATA7	M4	MDATA21	R4	VDD
F17	VDD	J17	$\overline{\text{EACEN}}$	M17	EMDATA8	R17	VDD
F18	EMDATA29	J18	$\overline{\text{EMWR}}$	M18	EMDATA7	R18	EMADD21
F19	EMDATA26	J19	EMDATA18	M19	EMDATA8	R19	EMADD23
F20	EMDATA24	J20	EMDATA17	M20	EMDATA9	R20	EMDATA0

**Table 2-1. MC92501 256-Lead GTBGA Package Signal List by Location (Continued)**

Location	Signal Name	Location	Signal Name	Location	Signal Name	Location	Signal Name
U1	TXPHYID2/ TXADDR2	V1	TXDATA1	W1	TXDAT5	Y1	VSS
U2	TXDATA0	V2	TXDATA4	W2	VDD	Y2	VDD
U3	TXDATA3	V3	TXDATA6	W3	VSS	Y3	$\overline{\text{TXPHYIDV}}$ / $\overline{\text{TXADDR4}}$
U4	VSS	V4	TXSOC	W4	TXDATA7	Y4	$\overline{\text{TXCCLR}}$
U5	TXPRTY	V5	$\overline{\text{TXFULL}}$	W5	$\overline{\text{TXENB}}$	Y5	$\overline{\text{STXENB}}$
U6	VDD	V6	STXDATA0	W6	STXDATA2	Y6	STXDATA3
U7	STXDATA1	V7	STXDATA4	W7	STXDATA5	Y7	STXDATA6
U8	VSS	V8	STXDATA7	W8	STXPRTY	Y8	STXSOC
U9	STXCLAV	V9	STXCLK	W9	ENID	Y9	TDI
U10	VDD	V10	TMS	W10	TDO	Y10	$\overline{\text{TRST}}$
U11	AMODE1	V11	AMODE0	W11	$\overline{\text{ARST}}$	Y11	TCK
U12	$\overline{\text{EMBSL1}}$	V12	$\overline{\text{EMBSL2}}$	W12	$\overline{\text{EMBSL3}}$	Y12	nc
U13	VSS	V13	$\overline{\text{EMBSH3}}$	W13	nc	Y13	$\overline{\text{EMBSL0}}$
U14	EMADD3	V14	VDD	W14	$\overline{\text{EMBSH1}}$	Y14	$\overline{\text{EMBSH2}}$
U15	VDD	V15	EMADD4	W15	nc	Y15	$\overline{\text{EMBSH0}}$
U16	EMADD9	V16	VSS	W16	EMADD5	Y16	EMADD2

**Table 2-2. MC92501 256-Lead GTBGA Package Signal List by Name**

Signal Name	Location	Signal Name	Location	Signal Name	Location	Signal Name	Location
A1	A10	EMADD21	R18	EMDATA10	L19	EMDATA29	F18
ACLK	A2	EMADD22	P17	EMDATA11	L18	EMDATA3	N18
AMODE0	V11	EMADD23	R19	EMDATA12	L20	EMDATA30	E19
AMODE1	U11	EMADD3	U14	EMDATA13	K20	EMDATA31	D20
$\overline{\text{ARST}}$	W11	EMADD4	V15	EMDATA14	K19	EMDATA4	N19
AVDD	C2	EMADD5	W16	EMDATA15	K18	EMDATA5	N20
AVSS	B1	EMADD6	Y17	EMDATA16	K17	EMDATA7	M18
$\overline{\text{EACEN}}$	J17	EMADD7	W17	EMDATA17	J20	EMDATA8	M17
EMADD10	V17	EMADD8	Y18	EMDATA18	J19	EMDATA8	M19
EMADD11	W18	EMADD9	U16	EMDATA19	H20	EMDATA9	M20
EMADD12	Y19	$\overline{\text{EMBSH0}}$	Y15	EMDATA2	P20	$\overline{\text{EMWR}}$	J18
EMADD13	V18	$\overline{\text{EMBSH1}}$	W14	EMDATA20	H19	ENID	W9
EMADD14	U19	$\overline{\text{EMBSH2}}$	Y14	EMDATA21	H18	MADD10	D7
EMADD15	U18	$\overline{\text{EMBSH3}}$	V13	EMDATA22	G20	MADD11	C6
EMADD16	T17	$\overline{\text{EMBSL0}}$	Y13	EMDATA23	G19	MADD12	B5
EMADD17	V20	$\overline{\text{EMBSL1}}$	U12	EMDATA24	F20	MADD13	A4
EMADD18	U20	$\overline{\text{EMBSL2}}$	V12	EMDATA25	G18	MADD14	C5

**Table 2-2. MC92501 256-Lead GTBGA Package Signal List by Name (Continued)**

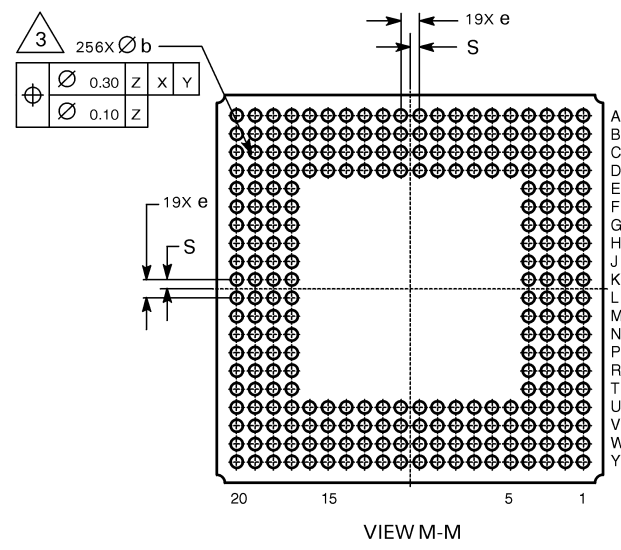
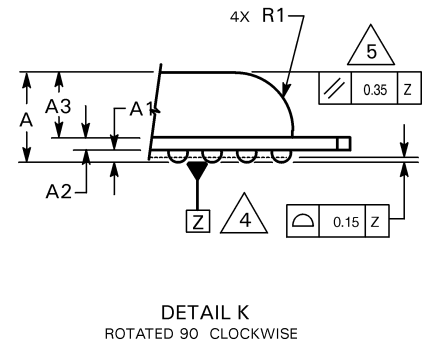
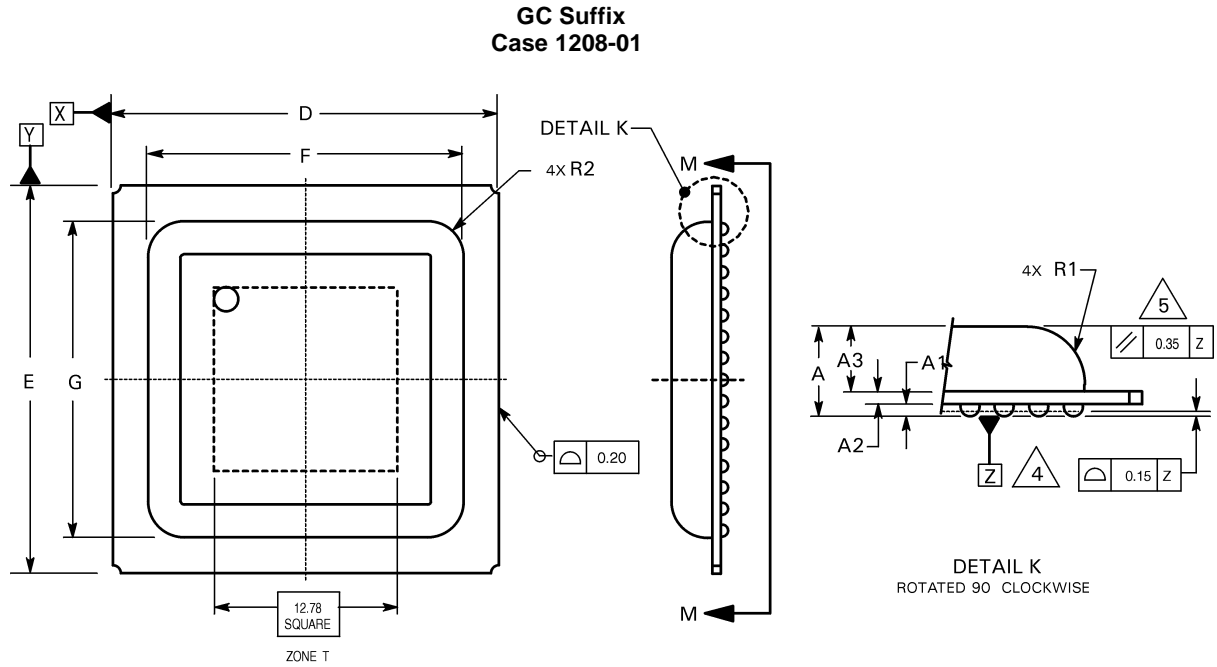
Signal Name	Location	Signal Name	Location	Signal Name	Location	Signal Name	Location
MADD18	C1	MDATA16	L3	$\overline{\text{MDTACK0}}$	B9	RXDATA7	C18
MADD19	D1	MDATA17	L4	$\overline{\text{MDTACK1}}$	D14	$\overline{\text{RXEMPTY}}$	C16
MADD2	B8	MDATA18	M1	$\overline{\text{MINT}}$	A9	$\overline{\text{RXENB}}$	B16
MADD20	E3	MDATA19	M2	$\overline{\text{MREQ0}}$	D9	RXPHYID0	C17
MADD21	E2	MDATA2	G2	$\overline{\text{MREQ1}}$	C9	RXPHYID1	D16
MADD22	E1	MDATA20	M3	$\overline{\text{MREQ2}}$	D10	RXPHYID2	A18
MADD23	F3	MDATA21	M4	$\overline{\text{MSEL}}$	A8	RXPHYID3	A17
MADD24	G4	MDATA22	N1	$\overline{\text{MWR}}$	B10	RXPRTY	B17
MADD25	F2	MDATA23	N2	$\overline{\text{MWSH}}$	A10	RXSOC	A16
MADD3	C8	MDATA24	N3	$\overline{\text{MWSL}}$	A11	SIZE	A11
MADD4	A7	MDATA25	P1	nc	W13	SRXCLAV	C14
MADD5	B7	MDATA26	P2	nc	W15	SRXCLK	B14
MADD6	A6	MDATA27	R1	nc	Y12	SRXDATA0	A14
MADD7	C7	MDATA28	P3	RXADDR0	C17	SRXDATA1	C13
MADD8	B6	MDATA29	R2	RXADDR1	D16	SRXDATA2	B13
MADD9	A5	MDATA3	G1	RXADDR2	A18	SRXDATA3	A13
MCLK	C10	MDATA30	T1	RXADDR3	A17	SRXDATA4	D12

**Table 2-2. MC92501 256-Lead GTBGA Package Signal List by Name (Continued)**

Signal Name	Location	Signal Name	Location	Signal Name	Location	Signal Name	Location
STXDATA0	V6	TXADDR4	Y3	VDD	C4	VSS	A20
STXDATA1	U7	$\overline{\text{TXCCLR}}$	Y4	VDD	D11	VSS	B3
STXDATA2	W6	TXDAT5	W1	VDD	D15	VSS	D13
STXDATA3	Y6	TXDATA0	U2	VDD	D3	VSS	D17
STXDATA4	V7	TXDATA1	V1	VDD	D6	VSS	D4
STXDATA5	W7	TXDATA2	T4	VDD	F17	VSS	D8
STXDATA6	Y7	TXDATA3	U3	VDD	F4	VSS	E4
STXDATA7	V8	TXDATA4	V2	VDD	K4	VSS	H17
$\overline{\text{STXENB}}$	Y5	TXDATA6	V3	VDD	L17	VSS	H4
STXPRTY	W8	TXDATA7	W4	VDD	P18	VSS	N17
STXSOC	Y8	$\overline{\text{TXENB}}$	W5	VDD	R17	VSS	N4
TCK	Y11	$\overline{\text{TXFULL}}$	V5	VDD	R4	VSS	T18
TDI	Y9	TXPHYID0	R3	VDD	U10	VSS	U13
TDO	W10	TXPHYID1	T2	VDD	U15	VSS	U17
TESTOUT	C3	TXPHYID2	U1	VDD	U6	VSS	U4
TESTSEL	B2	TXPHYID3	T3	VDD	V14	VSS	U8
TMS	V10	$\overline{\text{TXPHYIDV}}$	Y3	VDD	V19	VSS	V16



## 2.3 GTBGA Mechanical Drawing



- NOTES:**
1. DIMENSIONS ARE IN MILLIMETERS.
  2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
  3. DIMENSION b IS MEASURED AT THE MAXIMUM SOLDER BALL DIAMETER, PARALLEL TO DATUM PLANE Z.
  4. DATUM Z (SEATING PLANE) IS DEFINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.
  5. PARALLELISM REQUIREMENT APPLIES TO ZONE T ONLY. PARALLELISM REQUIREMENT SHALL EXCLUDE ANY EFFECT OF LASER MARK ON TOP SURFACE OF PACKAGE.

MILLIMETERS		
DIM	MIN	MAX
A	---	2.83
A1	0.50	0.70
A2	0.56 REF	
A3	1.15	1.49
b	0.65	0.85
D	27.00 BSC	
E	27.00 BSC	
e	1.27 BSC	
F	17.78	24.00
G	17.78	24.00
R1	2.50 REF	
R2	0.40	2.50
R1	0.635 BSC	

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## Specifications

## 3.1 Introduction

This section provides the following sets of physical and electrical specifications for the MC92501:

- Absolute Maximum Ratings
- Recommended Operating Conditions
- DC Electrical Characteristics
- Clocks
- Microprocessor Interface Timing
- PHY Interface Timing
- Switch Interface Timing
- External Memory Interface Timing

## 3.2 Absolute Maximum Ratings

**Table 3-1. Absolute Maximum Ratings**

Symbol	Parameter	Value/Value Range <sup>1</sup>	Unit
$V_{DD}$	DC Supply Voltage	-0.5 to 3.8	V
$V_{IN}$ <sup>2</sup>	DC Input Voltage (5 V Tolerant)	-0.5 to 5.8	V
$V_{OUT}$ <sup>2,3</sup>	DC Output Voltage	-0.5 to $V_{DD} + 0.5$	V
I	DC Current Drain per Pin, Any Single Input or Output	±50	mA
I	DC Current Drain VDD and VSS Pins	±100	mA
$T_{STG}$	Storage Temperature	-65 to +150	°C
$T_L$	Lead Temperature (10 s soldering)	300	°C

- Notes:**
1. Maximum ratings are those values beyond which damage to the device may occur.
  2. All input, bidirectional, and MDTACK are 5 V Tolerant. For proper operation it is recommended that  $V_{IN}$  and  $V_{OUT}$  be constrained to  $0 \leq (V_{IN}, V_{OUT}) \leq 5.5$  V.
  3. SRXDATAx, SRXSOC, SRXPRTY, TDO tri-state outputs must be constrained to  $0 \leq V_{OUT} \leq V_{DD}$  in the high impedance state.
  4. This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to this high impedance circuit.

## 3.3 Recommended Operating Conditions

### 3.4 DC Electrical Characteristics

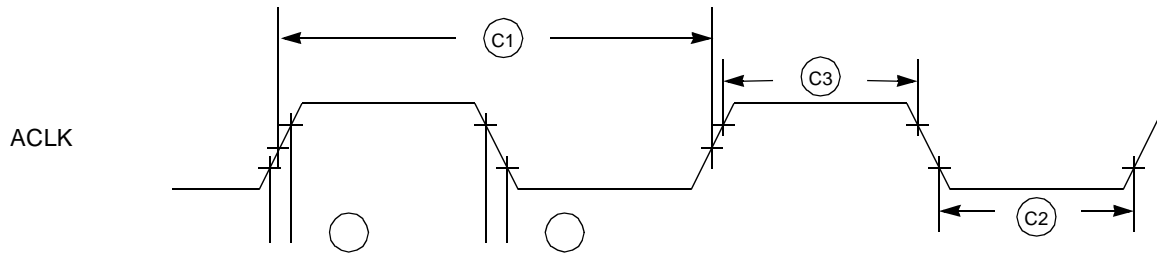
**Table 3-3. DC Electrical Characteristics**

Symbol	Parameter	Condition	Min.	Max.	Unit
$V_{IH}$	TTL Inputs (5V Tolerant)	—	2.2	5.5	V
$V_{IL}$	TTL Inputs (5V Tolerant)	—	-0.3	0.8	V
$I_{IN}$	Input Leakage Current, No Pull Resistor	$V_{IN} = V_{DD}$ or $V_{SS}$	-5	5	$\mu A$
	With Pullup Resistor *		-50	-5	
	With Pulldown Resistor *		5	50	
$I_{OH}$	Output High Current, LVTTL Output Type Outputs: <u>EACEN</u> , <u>EMWR</u> , <u>EMADDx</u> , <u>EMBSHx</u> , <u>EMBSLx</u>	$V_{DD} = \text{Min}$ , $V_{OH} \text{ Min} = 0.8 V_{DD}$	-24	—	mA
	Output High Current, LVTTL Output Type Outputs: All other outputs		-4	—	
$I_{OL}$	Output Low Current, LVTTL Output Type Outputs: <u>EACEN</u> , <u>EMWR</u> , <u>EMADDx</u> , <u>EMBSHx</u> , <u>EMBSLx</u>	$V_{DD} = \text{Min}$ , $V_{OL} \text{ Max} = 0.4 V$	24	—	mA
	Output Low Current, LVTTL Output Type Outputs: All other outputs		4	—	
$I$	Output Leakage Current,	Output = High Impedance	-10	10	$\mu A$

### 3.5 Clocks

**Table 3-4. Clock Timing**

Num	Characteristics	Min	Max	Unit
C1	ACLK Cycle Time	39	80	ns
C2	ACLK Pulse Width Low	15	—	ns
C3	ACLK Pulse Width High	15	—	ns
C4	ACLK Rise/Fall Time	—	5	ns
C5	MCLK Cycle Time	30	—	ns
C6	MCLK Pulse Width Low	12	—	ns
C7	MCLK Pulse Width High	12	—	ns
C8	MCLK Rise/Fall Time	—	5	ns
C9	SRXCLK/STXCLK Cycle Time	30	—	ns
C10	SRXCLK/STXCLK Pulse Width Low	12	—	ns
C11	SRXCLK/STXCLK Pulse Width High	12	— </td <td>ns</td>	ns
C12	SRXCLK/STXCLK Rise/Fall Time	—	5	ns



### 3.6 Microprocessor Interface Timing

The timing diagrams in this section are intended to convey setup and hold values for input signals and propagation delay values for output signals. For functional timing diagrams, see Section 4.5 Microprocessor Interface.

**Table 3-5. Microprocessor Interface Timings**

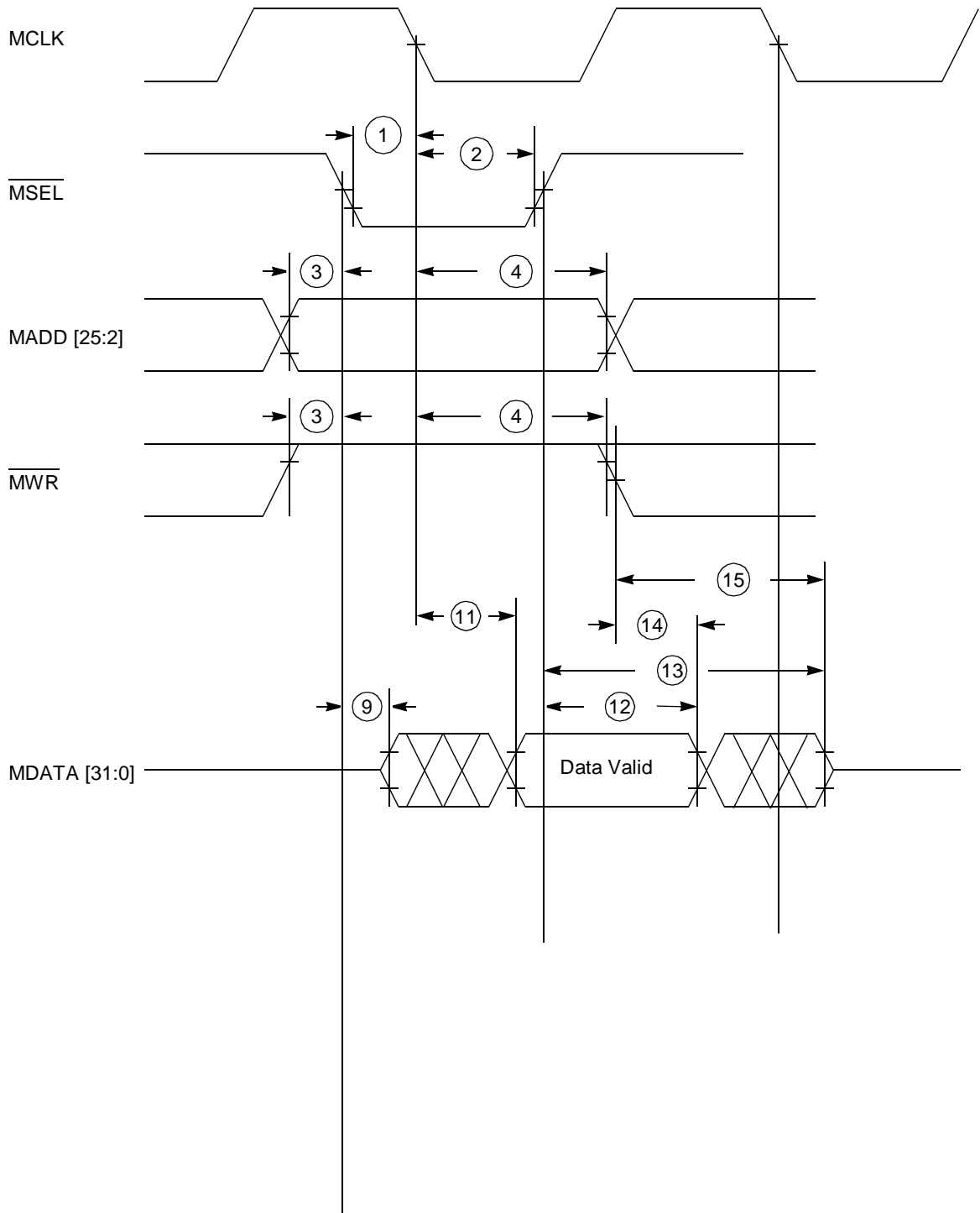
Num	Characteristics	Min	Max	Unit
1	$\overline{\text{MSEL}}$ setup time before MCLK falling edge	5		ns
2	$\overline{\text{MSEL}}$ hold time after MCLK falling edge	1		ns
3	MADD/ $\overline{\text{MWR}}$ setup time before $\overline{\text{MSEL}}$ assertion	5		ns
4	MADD/ $\overline{\text{MWR}}$ hold time after MCLK falling edge <sup>1</sup>	3		ns
5	$\overline{\text{MDS}}$ setup time before MCLK falling edge	5		ns
6	$\overline{\text{MDS}}$ hold time after MCLK falling edge	1		ns
7	MDATA setup time before MCLK falling edge	4		ns
8	MDATA hold time after MCLK falling edge	1		ns
9	$\overline{\text{MSEL}}$ assertion to MDATA active	0		ns
11	MCLK falling edge to MDATA valid for CER Accesses <sup>2</sup>		26	ns
12	$\overline{\text{MSEL}}$ deassertion to MDATA invalid	1		ns
13	$\overline{\text{MSEL}}$ deassertion to MDATA inactive		11	ns
14	$\overline{\text{MWR}}$ assertion to MDATA invalid	1		ns
15	$\overline{\text{MWR}}$ assertion to MDATA inactive		11	ns

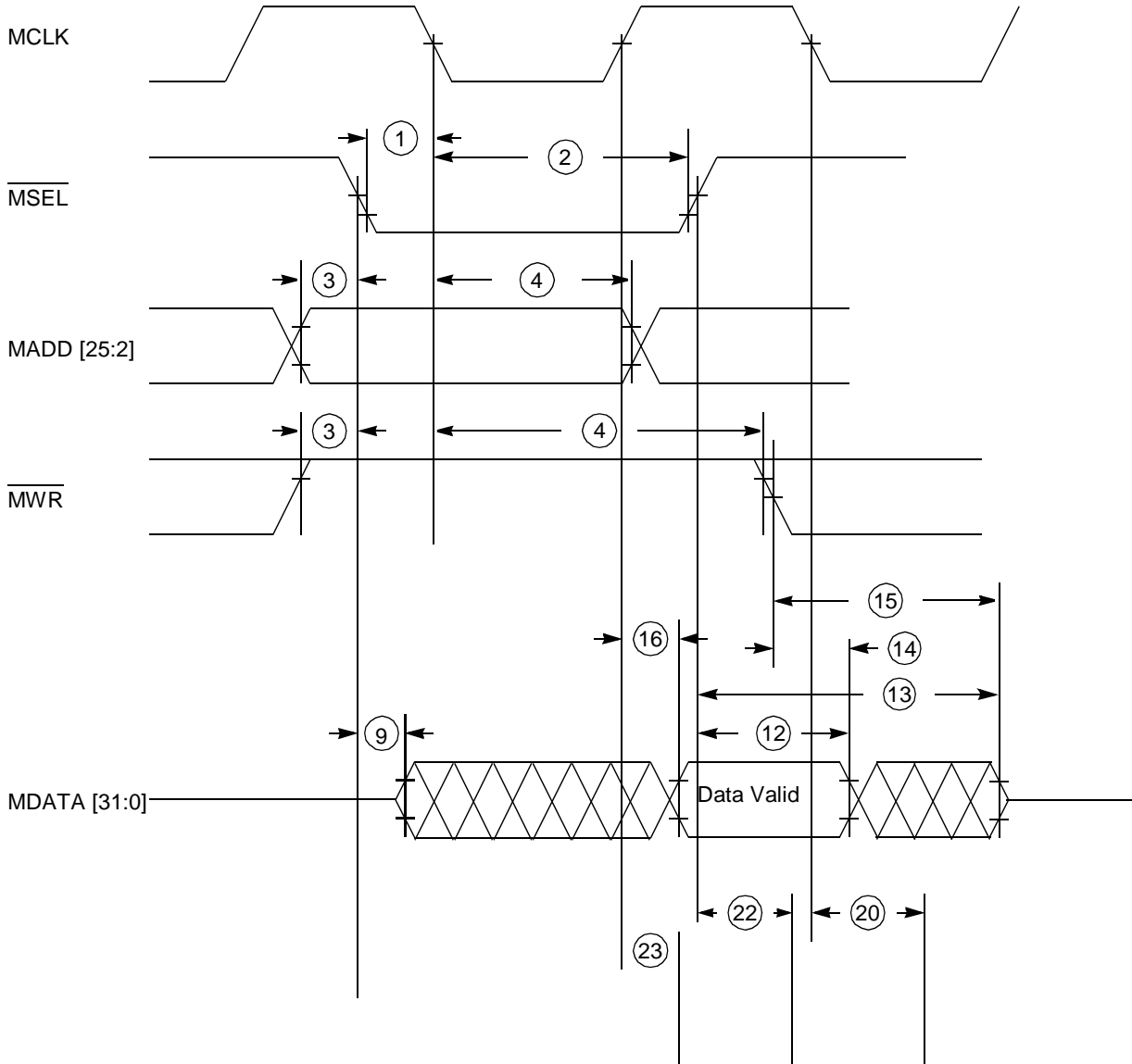
**Table 3-5. Microprocessor Interface Timings (Continued)**

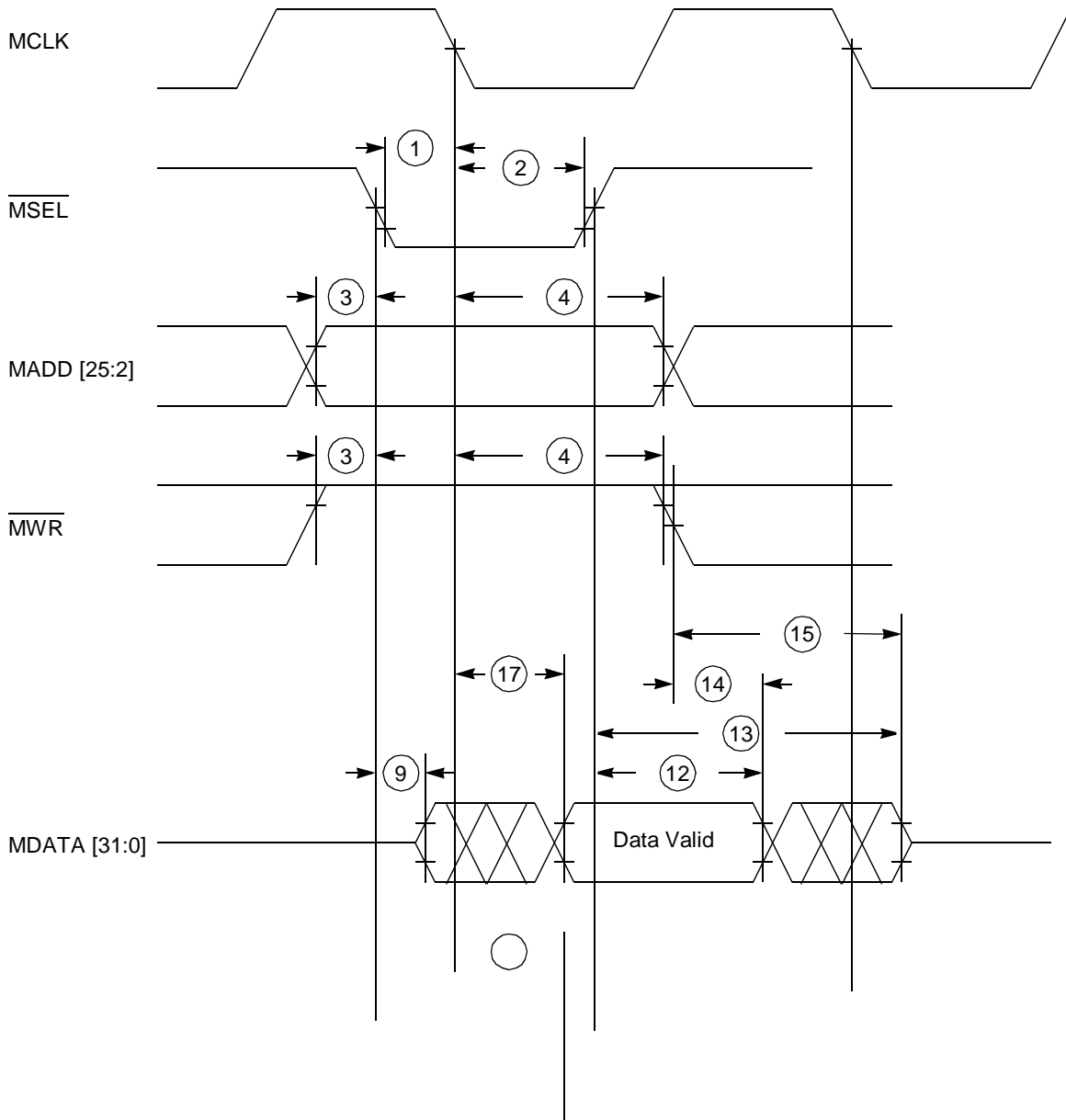
Num	Characteristics	Min	Max	Unit
27	MCLK falling edge to $\overline{\text{MDTACK}}$ asserted for General Register Read Accesses <sup>5,6</sup>		$T_{RD}$	ns
28	MCLK falling edge to $\overline{\text{MDTACK}}$ asserted for General Register Write Accesses <sup>5,7</sup>		$T_{WD}$	ns
29	Access width (MCLK falling edge to $\overline{\text{MSEL}}$ deassertion) for General Register Write Accesses <sup>8</sup>	$T_W$		
30	$\overline{\text{MSEL}}$ assertion to $\overline{\text{MDTACK1}}$ asserted <sup>9</sup>		12	ns
31	$\overline{\text{MDTACK0}}$ assertion to $\overline{\text{MDTACK1}}$ assertion	0	5	ns

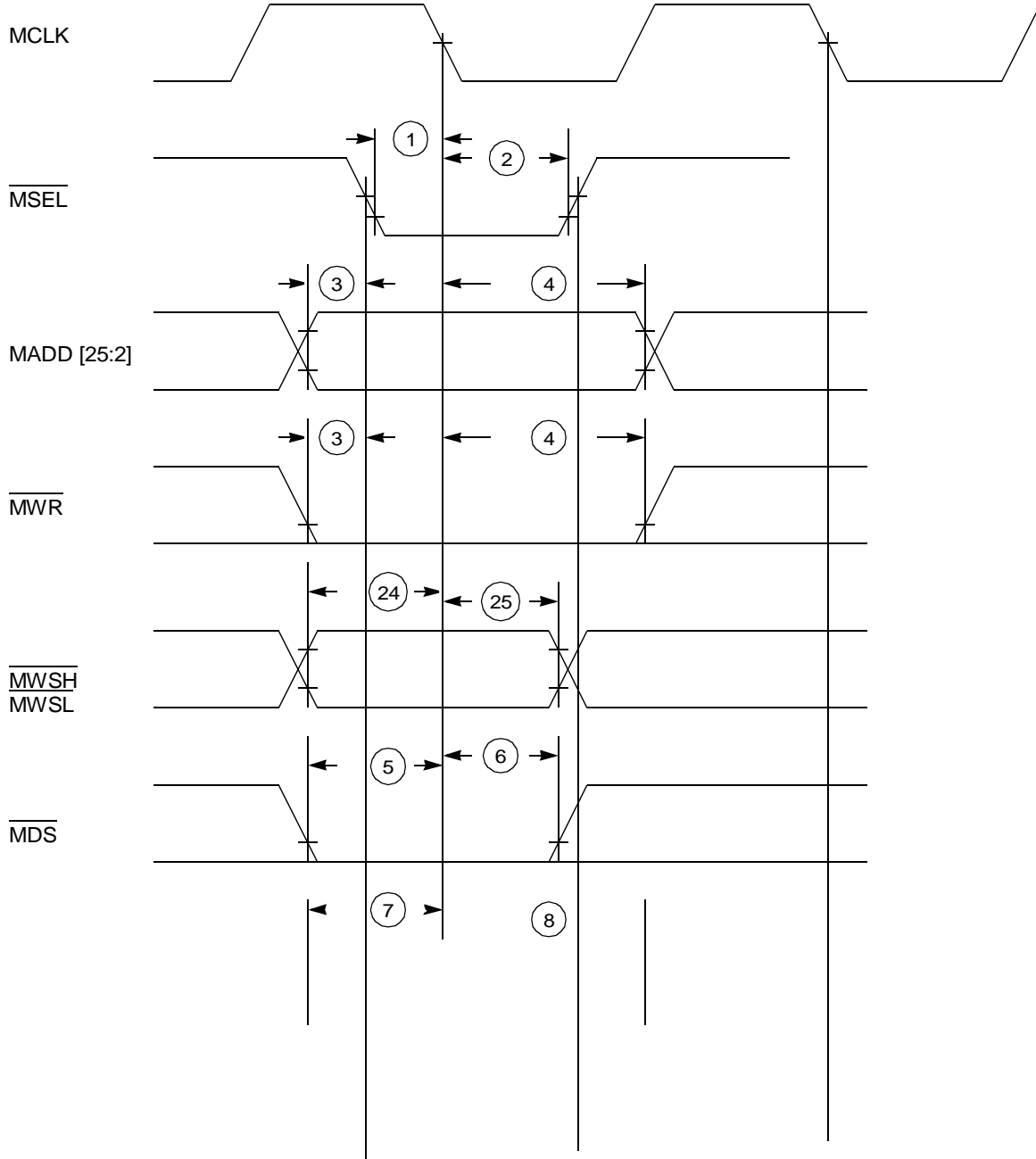
- Notes:**
1. This refers only to the first falling edge of MCLK in each access at which  $\overline{\text{MSEL}}$  is asserted.
  2. This is for a 150 pF load. Add 0.9 ns for each additional 10 pF. For a 100 pF load, subtract 4 ns.
  3.  $T_D$  = External Memory access time + 18 ns
  4.  $T_R$  = 4 \* ACLK period + 20 ns
  5. This is for a 50 pF load.
  6.  $T_{RD}$  = 4 \* ACLK period + 11 ns
  7.  $T_{WD}$  is measured from the MCLK falling edge at which  $\overline{\text{MDS}}$  is sampled as asserted.  
 $T_{WD}$  = 4 \* ACLK period + 11 ns
  8.  $T_W$  is measured from the MCLK falling edge at which MDS is sampled as asserted.  $T_W$  = 4 \* ACLK period. Note that the setup and hold times with respect to MCLK (timing values 1 and 2) still apply.
  9. This is for a 50 pF load.











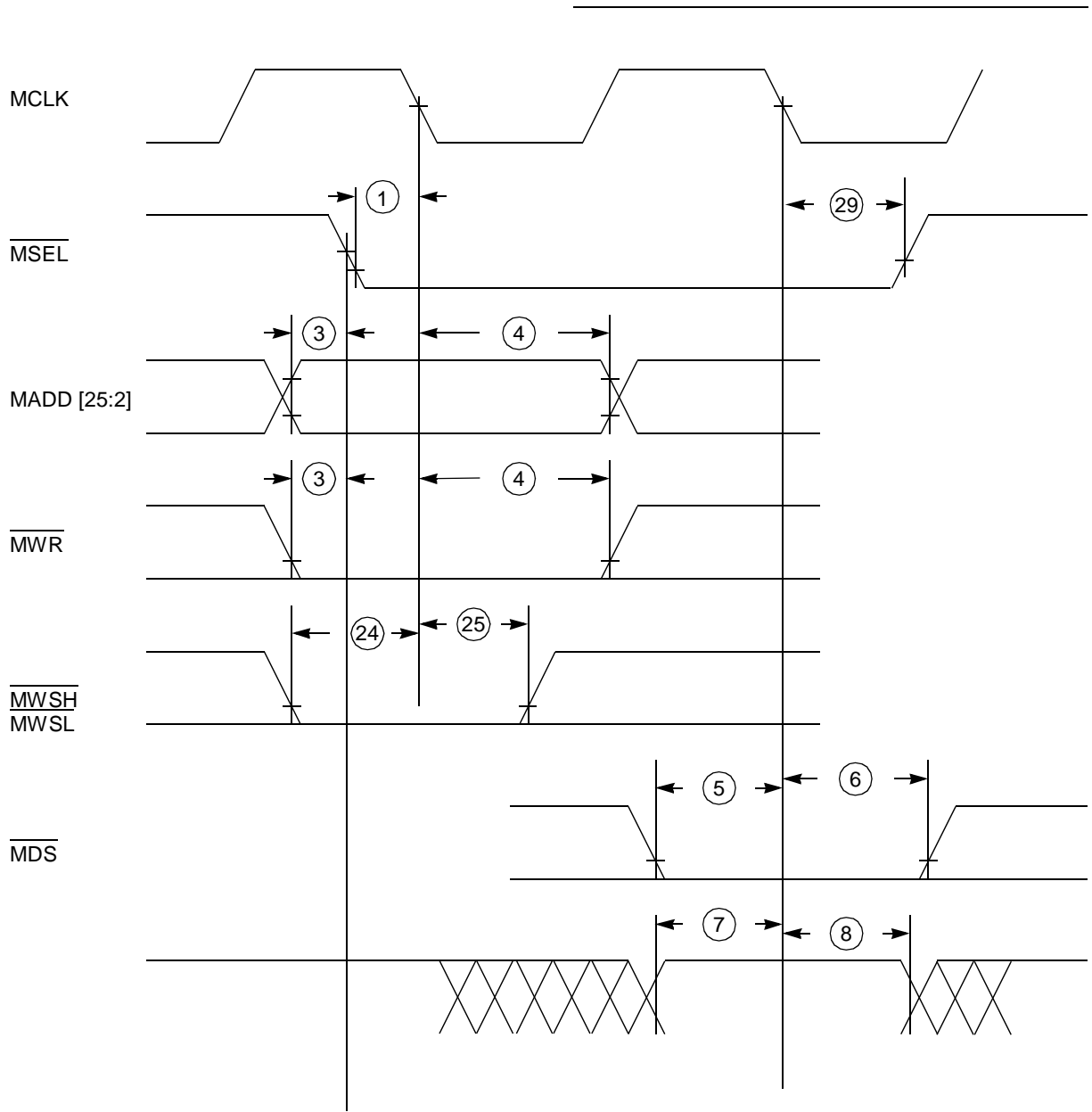


Figure 3-7. DMA Request Signals Timing

### 3.7 PHY Interface Timing

Table 3-6. PHY Interface Timings

Num	Characteristics	Min	Max	Unit
51	Setup time before ACLK rising edge	10	—	ns
52	Hold time after ACLK rising edge	1	—	ns
53	Propagation delay from rising edge of ACLK <sup>1</sup>	1	16 <sup>2</sup>	ns

**Notes:** 1. For a 200 pF load. Add 0.25 ns for each additional 10 pF. For 100 pF subtract 2.5 ns.  
 2. 16 ns for 70°C, 17 ns for 85°C

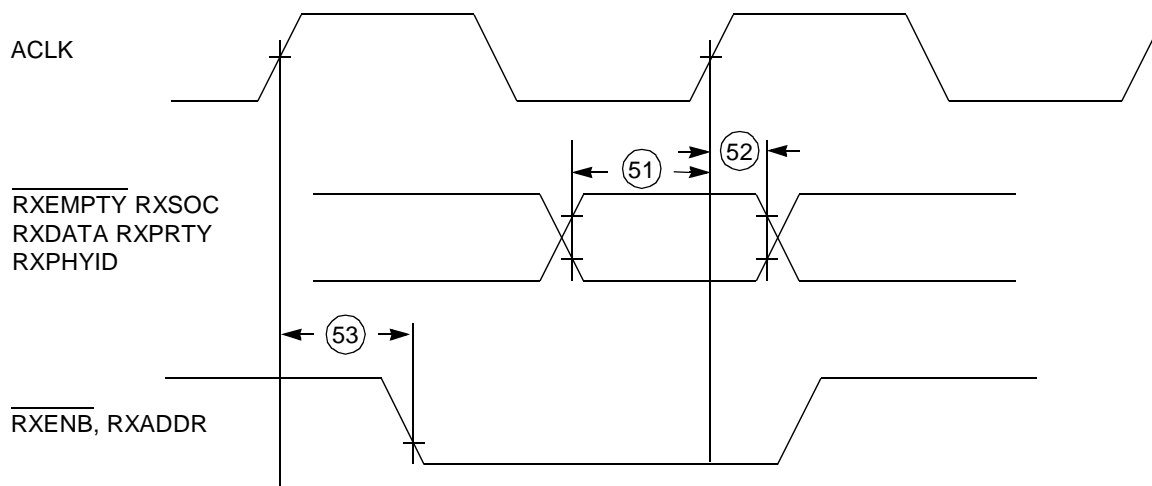
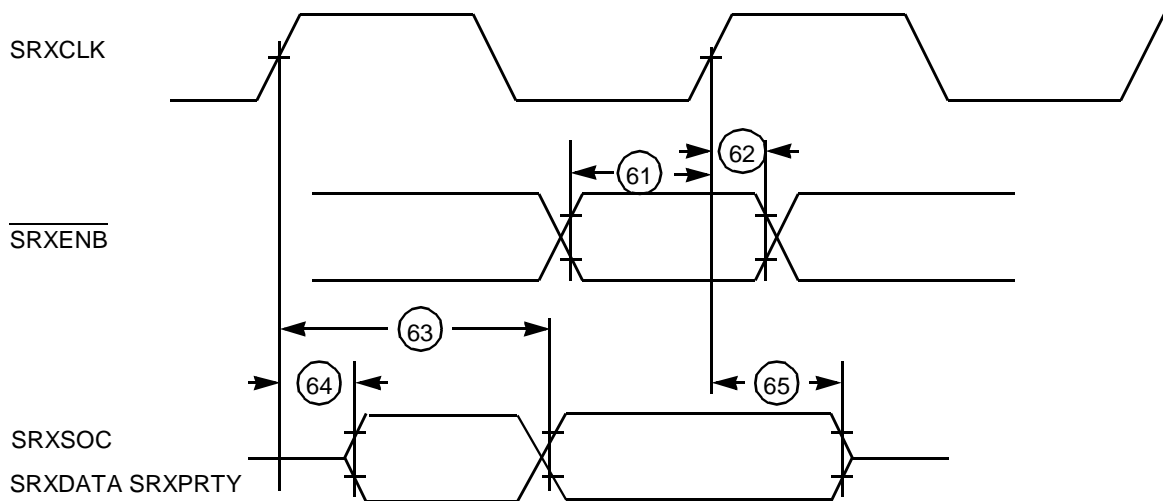


Figure 3-8. Receive PHY Interface Timing

### 3.8 Switch Interface Timing

**Table 3-7. Switch Interface Timing**

Num	Characteristics	Min	Max	Unit
61	Setup time before SRXCLK/STXCLK rising edge	4		ns
62	Hold time after SRXCLK/STXCLK rising edge	1		ns
63	Propagation delay from rising edge of SRXCLK/STXCLK	1	18	ns
64	SRXCLK rising edge to outputs active	1		
65	SRXCLK rising edge to outputs inactive	1	16	



**Figure 3-10. Ingress Switch Interface Timing**

### 3.9 External Memory Interface Timing

This section represents External Memory timing parameters for the default definition of the External Memory Timing Configuration Register (EMTCR). These values are for a load of up to 50 pF, which is the rated maximum load for the External Memory interface pins.

#### 3.9.1 Write Cycle Timing

**Table 3-8. Write Cycle Timing**

Num	Characteristics	Min	Max	Unit
81	Write Pulse Width	16	—	ns
82	$\overline{\text{EMWR}}$ assertion time. $\overline{\text{EMWR}}$ low to end of Write.	22	—	ns
83	Address Setup Time. EMADD Valid to Beginning of Write.	6	—	ns
84	Address Valid Time. During this Time EMADD is Valid.	32	—	ns
85	Address Hold Time. End of Write to EMADD Invalid.	6	—	ns
87	Data Setup Time. EMDATA Valid to End of Write.	13	—	ns
88	Data Hold Time. End of Write to EMDATA Invalid.	6	—	ns
<b>Note:</b> A write occurs during the overlap of $\overline{\text{EMBSH0-3}}$ , $\overline{\text{EMBSL0-3}}$ , $\overline{\text{EACEN}}$ low and $\overline{\text{EMWR}}$ low.				



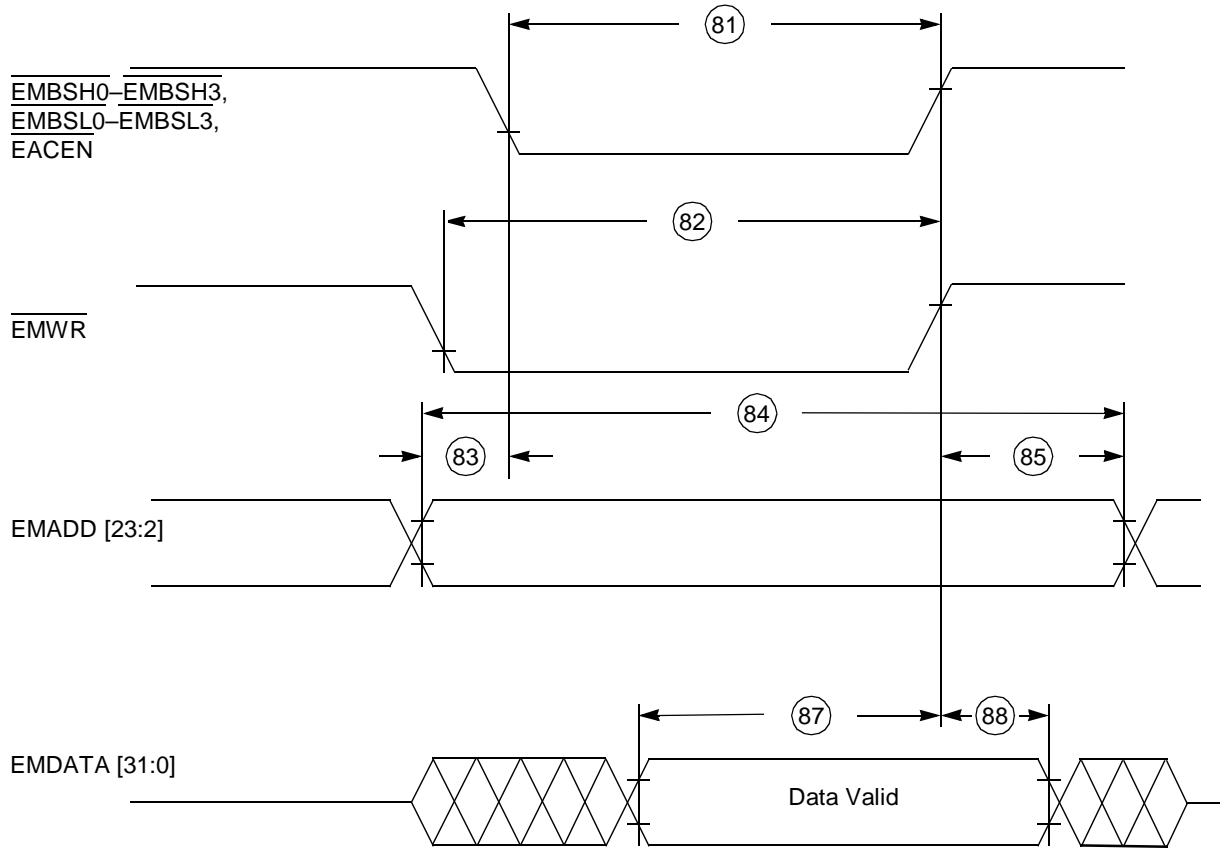


Figure 3-12. External Memory Write Access Timing

### 3.9.2 Read Cycle Timing

**Table 3-9. Read Cycle Timing**

Num	Characteristics	Min	Max	Unit
90	Enable Pulse Width. $\overline{\text{EMB}}\text{SH}0\text{--}\overline{\text{EMB}}\text{SH}3$ , $\overline{\text{EMB}}\text{SL}0\text{--}\overline{\text{EMB}}\text{SL}3$ , $\overline{\text{EAC}}\text{EN}$ Pulse Width.	28	—	ns
92	Address Setup Time. $\overline{\text{EMB}}\text{SH}0\text{--}\overline{\text{EMB}}\text{SH}3$ , $\overline{\text{EMB}}\text{SL}0\text{--}\overline{\text{EMB}}\text{SL}3$ , $\overline{\text{EAC}}\text{EN}$ High.	33	—	ns
93	Address Hold Time. $\overline{\text{EM}}\text{ADD}$ Invalid to $\overline{\text{EMB}}\text{SH}0\text{--}\overline{\text{EMB}}\text{SH}3$ , $\overline{\text{EMB}}\text{SL}0\text{--}\overline{\text{EMB}}\text{SL}3$ , $\overline{\text{EAC}}\text{EN}$ High	—	1 <sup>1</sup>	ns
94	Data Driving Start Point. $\overline{\text{EMB}}\text{SH}0\text{--}\overline{\text{EMB}}\text{SH}3$ , $\overline{\text{EMB}}\text{SL}0\text{--}\overline{\text{EMB}}\text{SL}3$ , $\overline{\text{EAC}}\text{EN}$ Low to $\overline{\text{EM}}\text{DATA}$ Active.	0	—	ns
95	Data Setup Time. $\overline{\text{EM}}\text{DATA}$ Valid to $\overline{\text{EMB}}\text{SH}0\text{--}\overline{\text{EMB}}\text{SH}3$ , $\overline{\text{EMB}}\text{SL}0\text{--}\overline{\text{EMB}}\text{SL}3$ , $\overline{\text{EAC}}\text{EN}$ High.	5	—	ns
96	Data Hold Time. $\overline{\text{EMB}}\text{SH}0\text{--}\overline{\text{EMB}}\text{SH}3$ , $\overline{\text{EMB}}\text{SL}0\text{--}\overline{\text{EMB}}\text{SL}3$ , $\overline{\text{EAC}}\text{EN}$ High to $\overline{\text{EM}}\text{DATA}$ Invalid.	0	—	ns
97	Data Driving End Point. $\overline{\text{EMB}}\text{SH}0\text{--}\overline{\text{EMB}}\text{SH}3$ , $\overline{\text{EMB}}\text{SL}0\text{--}\overline{\text{EMB}}\text{SL}3$ , $\overline{\text{EAC}}\text{EN}$ High to $\overline{\text{EM}}\text{DATA}$ Inactive <sup>2</sup>	—	9	ns

- Notes:**
1. A RAM with hold time from address change to data change is required.
  2. Failure to meet this value may result in contention on  $\overline{\text{EM}}\text{DATA}$  if a write access follows.

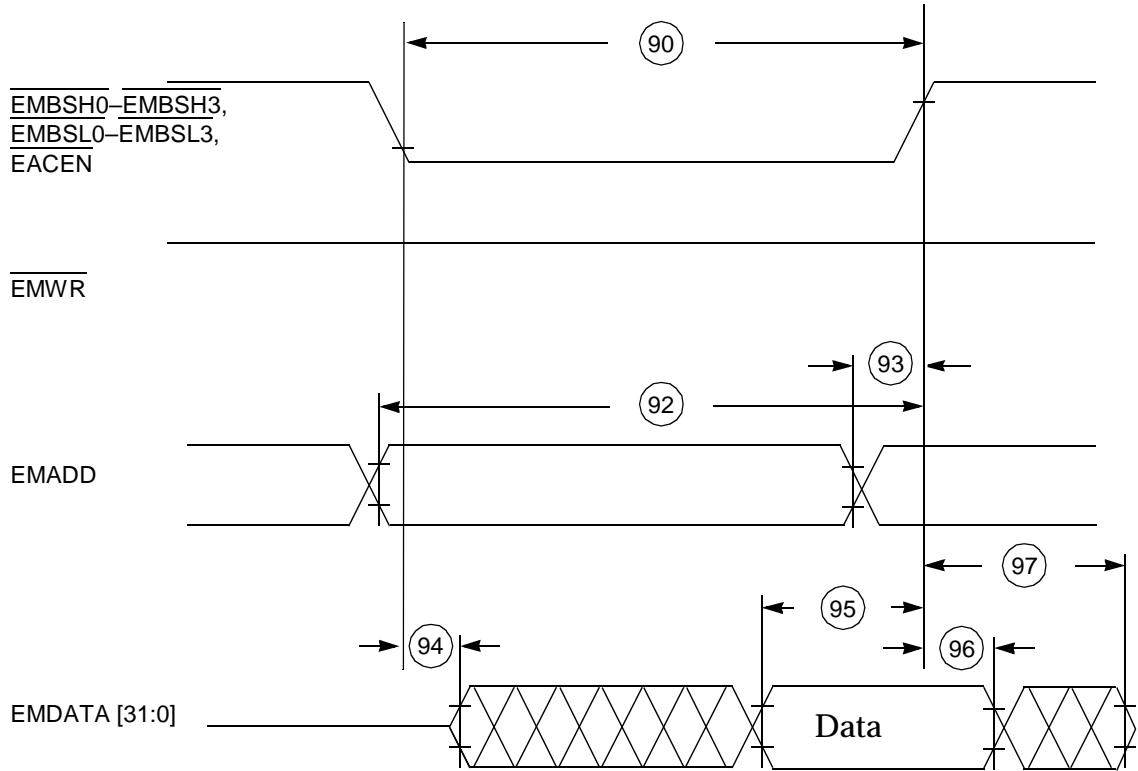


Figure 3-13. External Memory Read Access Timing



## Test Information

### 4.1 Device Identification Register

The code for the MC92501 is 0100\_0001\_1100\_0011\_1010\_0000\_0001\_1101.

### 4.2 Boundary Scan Register

**Table 4-1.** MC92501 Boundary Scan Bit Definition

Signal Name	I/O Cell Type	System Mode	Scan Bit #		Output Enable
STXCLK	in	in	360	—	—
STXCLAV	bidir	out	359	358	—
STXSOC	bidir	in	357	356	—
STXPRTY	bidir	in	355	354	—

**Table 4-1. MC92501 Boundary Scan Bit Definition (Continued)**

Signal Name	I/O Cell Type	System Mode	Scan Bit #		Output Enable
TXPHYIDV	tri-state	out	330	—	—
TXPRTY	bidir	out	329	328	—
TXSOC	bidir	out	327	326	—
TXDATA7	bidir	out	325	324	—
TXDATA6	bidir	out	323	322	—
TXDATA5	bidir	out	321	320	—
TXDATA4	bidir	out	319	318	—
TXDATA3	bidir	out	317	316	—
TXDATA2	bidir	out	315	314	—
TXDATA1	bidir	out	313	312	—
TXDATA0	bidir	out	311	310	—
TXPHYID3	tri-state	out	309	—	—
TXPHYID2	tri-state	out	308	—	—
TXPHYID1	tri-state	out	307	—	—
TXPHYID0	tri-state	out	306	—	—
MDATA31	bidir	bidir	305	304	enscan1
MDATA30	bidir	bidir	303	302	enscan1

**Table 4-1. MC92501 Boundary Scan Bit Definition (Continued)**

<b>Signal Name</b>	<b>I/O Cell Type</b>	<b>System Mode</b>	<b>Scan Bit #</b>		<b>Output Enable</b>
MDATA17	bidir	bidir	277	276	enscan1
MDATA16	bidir	bidir	275	274	enscan1
MDATA15	bidir	bidir	273	272	enscan1
MDATA14	bidir	bidir	271	270	enscan1
MDATA13	bidir	bidir	269	268	enscan1
MDATA12	bidir	bidir	267	266	enscan1
MDATA11	bidir	bidir	265	264	enscan1
MDATA10	bidir	bidir	263	262	enscan1
MDATA9	bidir	bidir	261	260	enscan1
MDATA8	bidir	bidir	259	258	enscan1
MDATA7	bidir	bidir	257	256	enscan1
MDATA6	bidir	bidir	255	254	enscan1
MDATA5	bidir	bidir	253	252	enscan1
MDATA4	bidir	bidir	251	250	enscan1
MDATA3	bidir	bidir	249	248	enscan1
MDATA2	bidir	bidir	247	246	enscan1
MDATA1	bidir	bidir	245	244	enscan1

**Table 4-1. MC92501 Boundary Scan Bit Definition (Continued)**

Signal Name	I/O Cell Type	System Mode	Scan Bit #		Output Enable
MADD14	bidir	in	219	218	—
MADD13	bidir	in	217	216	—
MADD12	bidir	in	215	214	—
MADD11	bidir	in	213	212	—
MADD10	bidir	in	211	210	—
MADD9	bidir	in	209	208	—
MADD8	bidir	in	207	206	—
MADD7	bidir	in	205	204	—
MADD6	bidir	in	203	202	—
MADD5	bidir	in	201	200	—
MADD4	bidir	in	199	198	—
MADD3	bidir	in	197	196	—
MADD2	bidir	in	195	194	—
MSEL	in	in	193	—	—
MREQ0	tri-state	out	192	—	—
MREQ1	tri-state	out	191	—	—
MDTACK0	tri-state	tri-state	190	enscan2	—



**Table 4-1. MC92501 Boundary Scan Bit Definition (Continued)**

Signal Name	I/O Cell Type	System Mode	Scan Bit #		Output Enable
SRXDATA4	bidir	tri-state	175	174	enscan4
SRXDATA3	bidir	tri-state	173	172	enscan4
SRXDATA2	bidir	tri-state	171	170	enscan4
SRXDATA1	bidir	tri-state	169	168	enscan4
SRXDATA0	bidir	tri-state	167	166	enscan4
SRXCLK	in	in	165	enscan4	—
SRXCLAV	bidir	out	164	163	—
SRXSOC	bidir	tri-state	162	161	enscan4
SRXPRTY	bidir	tri-state	160	159	enscan4
MDTACK1	tri-state	tri-state	158	enscan6	—
RXADDR4	tri-state	tri-state	157	enscan3	—
RXSOC	bidir	in	156	155	—
RXENB	bidir	out	154	153	—
RXEMPTY	bidir	in	152	151	—
RXPHYID3	bidir	bidir	150	149	enscan3
RXPHYID2	bidir	bidir	148	147	enscan3
RXPHYID1	bidir	bidir	146	145	enscan3

**Table 4-1. MC92501 Boundary Scan Bit Definition (Continued)**

Signal Name	I/O Cell Type	System Mode	Scan Bit #		Output Enable
EMDATA29	bidir	bidir	120	119	enscan5
EMDATA28	bidir	bidir	118	117	enscan5
EMDATA27	bidir	bidir	116	115	enscan5
EMDATA26	bidir	bidir	114	113	enscan5
EMDATA25	bidir	bidir	112	111	enscan5
EMDATA24	bidir	bidir	110	109	enscan5
EMDATA23	bidir	bidir	108	107	enscan5
EMDATA22	bidir	bidir	106	105	enscan5
EMDATA21	bidir	bidir	104	103	enscan5
EMDATA20	bidir	bidir	102	101	enscan5
EMDATA19	bidir	bidir	100	99	enscan5
EACEN	tri-state	out	98	—	—
EMWR	tri-state	out	97	—	—
EMDATA18	bidir	bidir	96	95	enscan5
EMDATA17	bidir	bidir	94	93	enscan5
EMDATA16	bidir	bidir	92	91	enscan5
EMDATA15	bidir	bidir	90	89	enscan5

**Table 4-1. MC92501 Boundary Scan Bit Definition (Continued)**

<b>Signal Name</b>	<b>I/O Cell Type</b>	<b>System Mode</b>	<b>Scan Bit #</b>		<b>Output Enable</b>
EMDATA2	bidir	bidir	64	63	enscan5
EMDATA1	bidir	bidir	62	61	enscan5
EMDATA0	bidir	bidir	60	59	enscan5
EMADD23	bidir	out	58	57	—
EMADD22	bidir	out	56	55	—
EMADD21	bidir	out	54	53	—
EMADD20	bidir	out	52	51	—
EMADD19	bidir	out	50	49	—
EMADD18	bidir	out	48	47	—
EMADD17	bidir	out	46	45	—
EMADD16	bidir	out	44	43	—
EMADD15	bidir	out	42	41	—
EMADD14	bidir	out	40	39	—
EMADD13	bidir	out	38	37	—
EMADD12	bidir	out	36	35	—
EMADD11	bidir	out	34	33	—
EMADD10	bidir	out	32	31	—

**Table 4-1. MC92501 Boundary Scan Bit Definition (Continued)**

<b>Signal Name</b>	<b>I/O Cell Type</b>	<b>System Mode</b>	<b>Scan Bit #</b>		<b>Output Enable</b>
EMBSL0	tri-state	out	10	—	—
EMBSL1	tri-state	out	9	—	—
EMBSL2	tri-state	out	8	—	—
EMBSL3	tri-state	out	7	—	—
ARST	in	in	6	—	—
enscan1	(core macro)	—	5	—	—
enscan2	(core macro)	—	4	—	—
enscan3	(core macro)	—	3	—	—
enscan4	(core macro)	—	2	—	—
enscan5	(core macro)	—	1	—	—
enscan6	(core macro)	—	0	—	—

## Ordering Information

**Table 5-1.** Ordering Information

<b>Part</b>	<b>Supply Voltage</b>	<b>Package Type</b>	<b>Pin Count</b>	<b>Order Number</b>
MC92501	3.3 V	Glob-Top Ball Grid Array (GTBGA)	256	MC92501GC



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